## Notice of References Cited

Ī	Application/Control No.	Applicant(s)/Pater	nt Under
	10/556,835	Reexamination GAEDKE ET AL.	
	Examiner	Art Unit	
ı	Brian J. Stevens	2611	Page 1 of 1

## II S PATENT DOCUMENTS

U.S. PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,641,364 A	02-1987	Bass et al.	340/7.2
*	В	US-2002/0045461 A1	04-2002	Bongfeldt, David	455/522
*	С	US-2002/0190203 A1	12-2002	Valaskovic et al.	250/288
*	D	US-2003/0151988 A1	08-2003	Katayama, Tatsushi	369/44.32
*	Е	US-6,788,753 B1	09-2004	Brown, Christopher T.	375/368
*	F	US-6,826,245 B1	11-2004	Brown et al.	375/368
	G	US-		-	
	Н	US-		-	
		US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002 216424	08-2002	Japan	Hirofumi	
	0					
	Р					
	Q					
	R					
	s					
	т					

NON-PATENT DOCUMENTS		
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
Γ	v	
	w	
	x	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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